

Search Notes

Application/Control No.

10/054,839

Examiner

Djenane M. Bayard

Applicant(s)/Patent under
Reexamination

PARKMAN ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
707	10	2/6/2006	DB
725	76	2/6/2006	DB
709	238	2/6/2006	DB
725	75	2/6/2006	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/6/2006	DB